CoolMOS™ Power Transistor

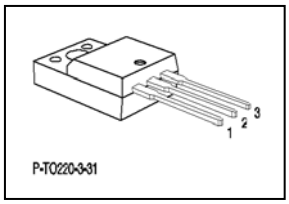
Features

- New revolutionary high voltage technology
- Ultra low gate charge
- Periodic avalanche rated
- High peak current capability
- Ultra low effective capacitances
- Extreme d*v*/d*t* rated
- Improved transconductance
- Fully isolated package (2500 V AC; 1 minute)
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC[0)] for target applications

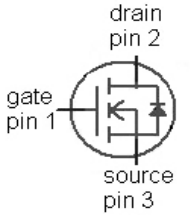
Product Summary

V_{DS} @ $T_{j,max}$	650	V
$R_{DS(on),max}$	0.75	Ω
I_D [1)]	6.2	A

PG-TO220-3-31



Type	Package	Ordering Code	Marking
SPA06N60C3	PG-TO220-3-31	SP000216301	06N60C3



Maximum ratings, at T_j=25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current[1)]	I_D	T_C=25 °C	6.2	A
		T_C=100 °C	3.9	
Pulsed drain current[1)]	$I_{D,pulse}$	T_C=25 °C	18.6	
Avalanche energy, single pulse	E_{AS}	I_D=3.1 A, V_{DD}=50 V	200	mJ
Avalanche energy, repetitive t_{AR}[1),2)]	E_{AR}	I_D=6.2 A, V_{DD}=50 V	0.5	
Avalanche current, repetitive t_{AR}[1)]	I_{AR}		6.2	A
Drain source voltage slope	d*v*/d*t*	I_D=6.2 A, V_{DS}=480 V, T_j=125 °C	50	V/ns
Gate source voltage	V_{GS}	static	±20	V
	V_{GS}	AC (*f*>1 Hz)	±30	
Power dissipation	P_{tot}	T_C=25 °C	32	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 150	°C
Reverse diode dv/dt [5)]	dv/dt		15	V/ns

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R_{thJC}		-	-	3.92	K/W
Thermal resistance, junction - ambient	R_{thJA}	leaded	-	-	80	
Soldering temperature, wavesoldering	T_{sold}	1.6 mm (0.063 in.) from case for 10 s	-	-	260	°C
Electrical characteristics, at T_j=25 °C, unless otherwise specified						
Static characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	V_{GS}=0 V, I_D=250 µA	600	-	-	V
Avalanche breakdown voltage	$V_{(BR)DS}$	V_{GS}=0 V, I_D=6.2 A	-	700	-	
Gate threshold voltage	$V_{GS(th)}$	V_{DS}=V_{GS}, I_D=0.26 mA	2.1	3	3.9	
Zero gate voltage drain current	I_{DSS}	V_{DS}=600 V, V_{GS}=0 V, T_j=25 °C	-	0.1	1	µA
		V_{DS}=600 V, V_{GS}=0 V, T_j=150 °C	-	-	100	
Gate-source leakage current	I_{GSS}	V_{GS}=20 V, V_{DS}=0 V	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	V_{GS}=10 V, I_D=3.9 A, T_j=25 °C	-	0.68	0.75	Ω
		V_{GS}=10 V, I_D=3.9 A, T_j=150 °C	-	1.82	-	
Gate resistance	R_G	f=1 MHz, open drain	-	1	-	
Transconductance	g_{fs}	$\|V_{DS}\|>2\|I_D\|R_{DS(on)max}$, I_D=3.9 A	-	5.6	-	S

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C_{iss}	V_{GS}=0 V, V_{DS}=25 V, f=1 MHz	-	620	-	pF
Output capacitance	C_{oss}		-	200	-	
Reverse transfer capacitance	C_{rss}		-	17	-	
Effective output capacitance, energy related[3)]	$C_{o(er)}$	V_{GS}=0 V, V_{DS}=0 V to 480 V	-	28	-	
Effective output capacitance, time related[4)]	$C_{o(tr)}$		-	47	-	
Turn-on delay time	$t_{d(on)}$	V_{DD}=480 V, V_{GS}=10 V, I_D=6.2 A, R_G=12 Ω	-	7	-	ns
Rise time	t_r		-	12	-	
Turn-off delay time	$t_{d(off)}$		-	52	-	
Fall time	t_f		-	10	-	
Gate Charge Characteristics						
Gate to source charge	Q_{gs}	V_{DD}=480 V, I_D=6.2 A, V_{GS}=0 to 10 V	-	3.3	-	nC
Gate to drain charge	Q_{gd}		-	12	-	
Gate charge total	Q_g		-	24	31	
Gate plateau voltage	$V_{plateau}$		-	5.5	-	V

1) Pulse width limited by maximum temperature $T_{j,max}$ only

2) Repetitive avalanche causes additional power losses that can be calculated as $P_{AV}=E_{AR}*f$.

3) $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

4) $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

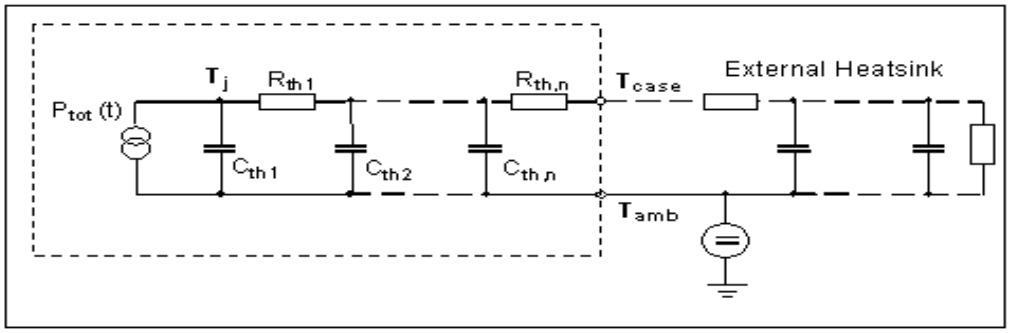
5) I_{SD}<=I_D, di/dt<=400A/us, V_{DClink}=400V, V_{peak}<$V_{BR, DSS}$, T_j<$T_{j,max}$.
Identical low-side and high-side switch.

0) J-STD20 and JESD22

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Reverse Diode						
Diode continuous forward current	I_S	T_C=25 °C	-	-	6.2	A
Diode pulse current	$I_{S,pulse}$		-	-	18.6	
Diode forward voltage	V_{SD}	V_{GS}=0 V, I_F=6.2 A, T_j=25 °C	-	0.97	1.2	V
Reverse recovery time	t_{rr}	V_R=480 V, I_F=I_S, di_F/dt=100 A/µs	-	400	-	ns
Reverse recovery charge	Q_{rr}		-	3.5	-	µC
Peak reverse recovery current	I_{rrm}		-	25	-	A

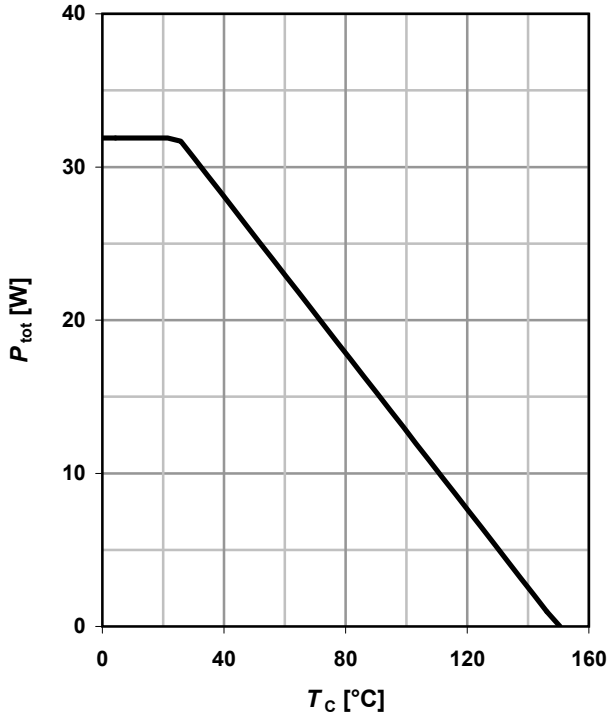
Typical Transient Thermal Characteristics

Symbol	Value	Unit	Symbol	Value	Unit
	typ.			typ.	
R_{th1}	0.034	K/W	C_{th1}	0.0000507	Ws/K
R_{th2}	0.15		C_{th2}	0.00045	
R_{th3}	0.388		C_{th3}	0.00117	
R_{th4}	0.713		C_{th4}	0.0114	
R_{th5}	1.6		C_{th5}	0.939	



1 Power dissipation

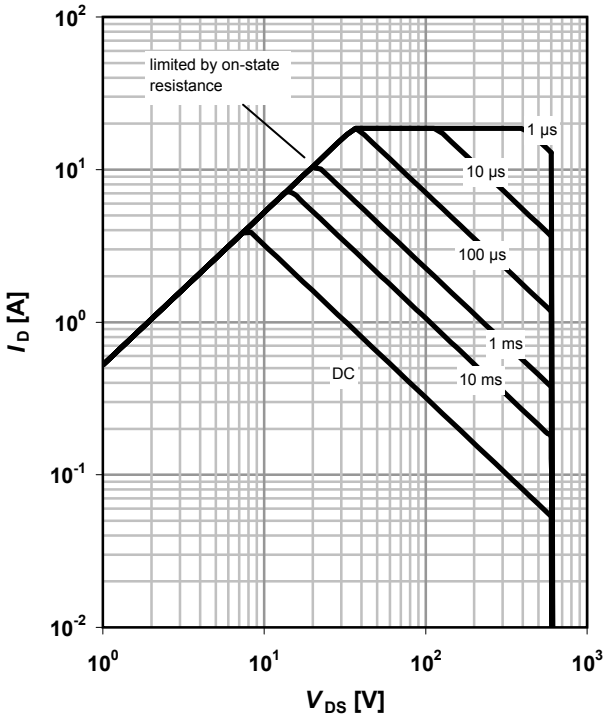
$P_{tot}=f(T_C)$



2 Safe operating area

$I_D=f(V_{DS})$; $T_C=25$ °C; $D=0$

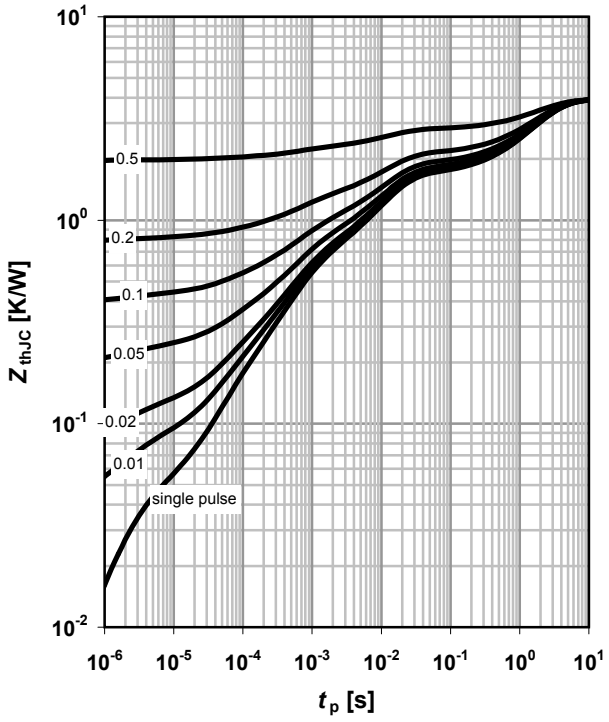
parameter: t_p



3 Max. transient thermal impedance

$I_D=f(V_{DS})$; $T_j=25$ °C

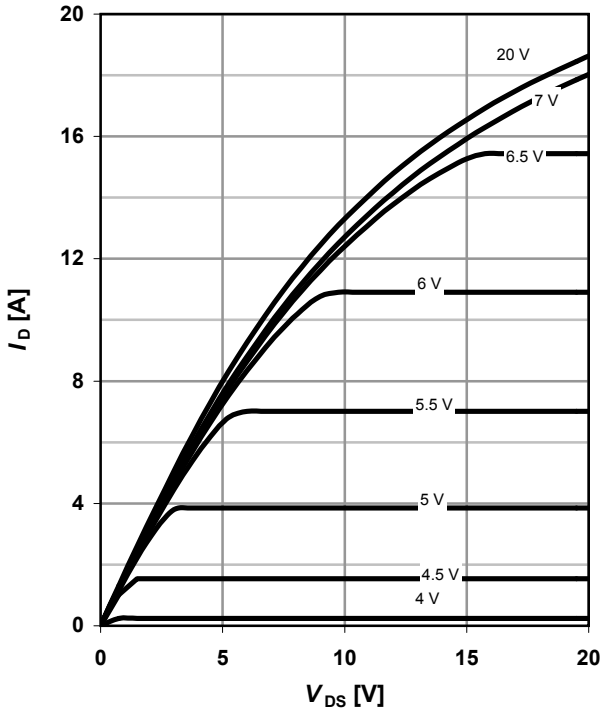
parameter: $D=t_p/T$



4 Typ. output characteristics

$I_D=f(V_{DS})$; $T_j=25$ °C

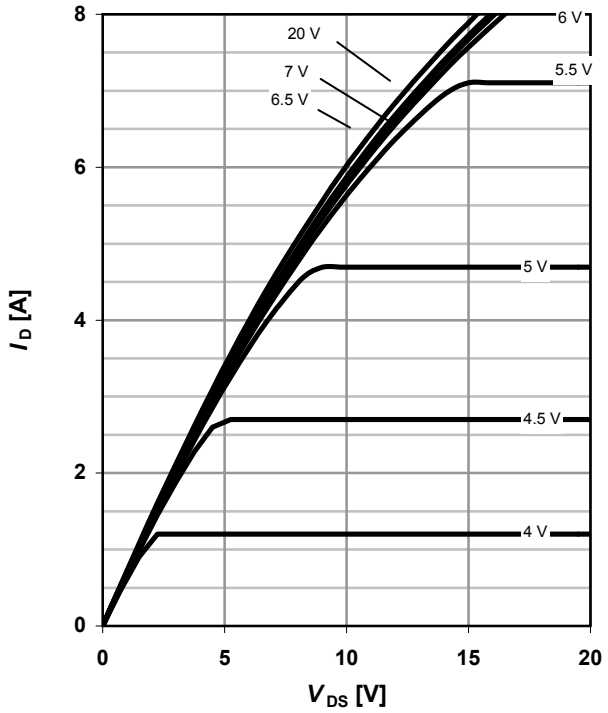
parameter: V_{GS}



5 Typ. output characteristics

$I_D=f(V_{DS})$; $T_j=150$ °C

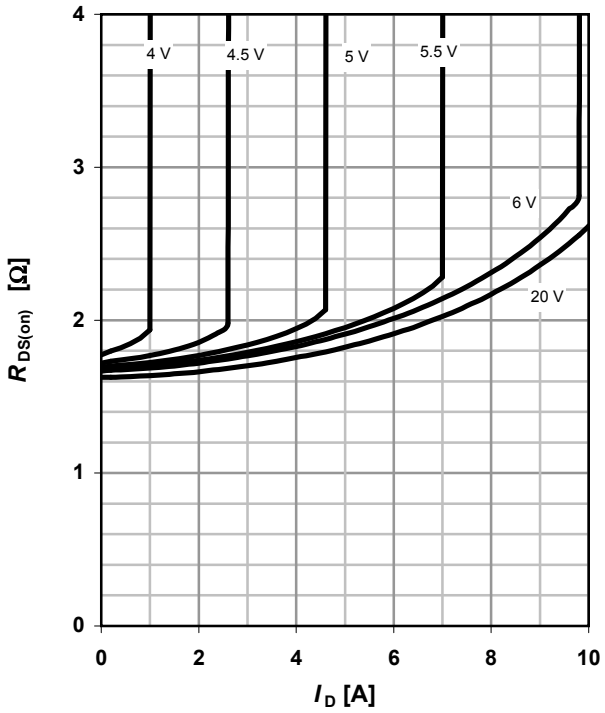
parameter: V_{GS}



6 Typ. drain-source on-state resistance

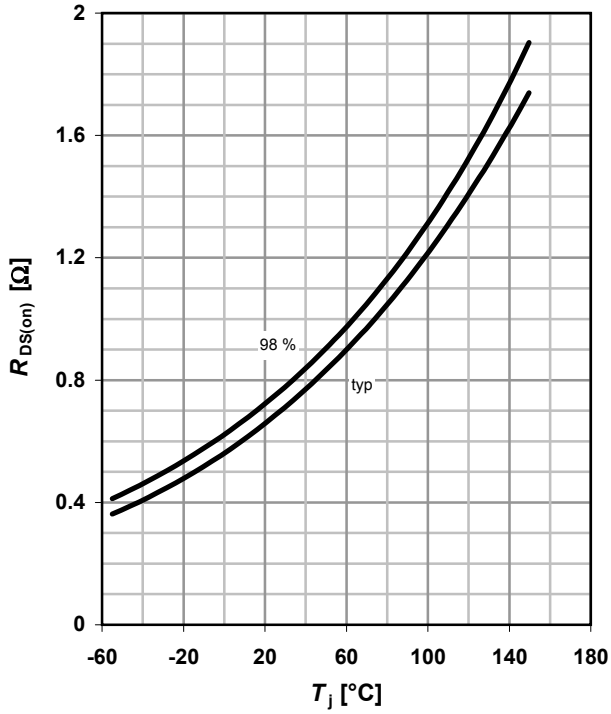
$R_{DS(on)}=f(I_D)$; $T_j=150$ °C

parameter: V_{GS}



7 Drain-source on-state resistance

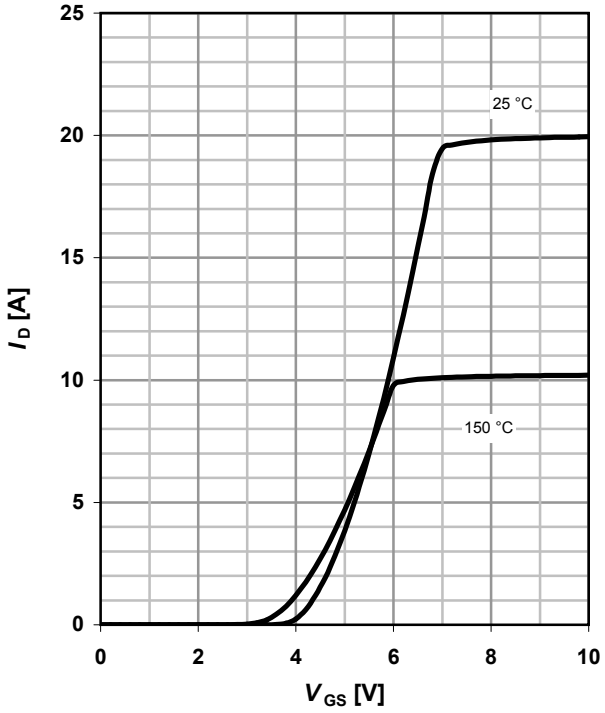
$R_{DS(on)}=f(T_j)$; $I_D=3.9$ A; $V_{GS}=10$ V



8 Typ. transfer characteristics

$I_D=f(V_{GS})$; $|V_{DS}|>2|I_D|R_{DS(on)max}$

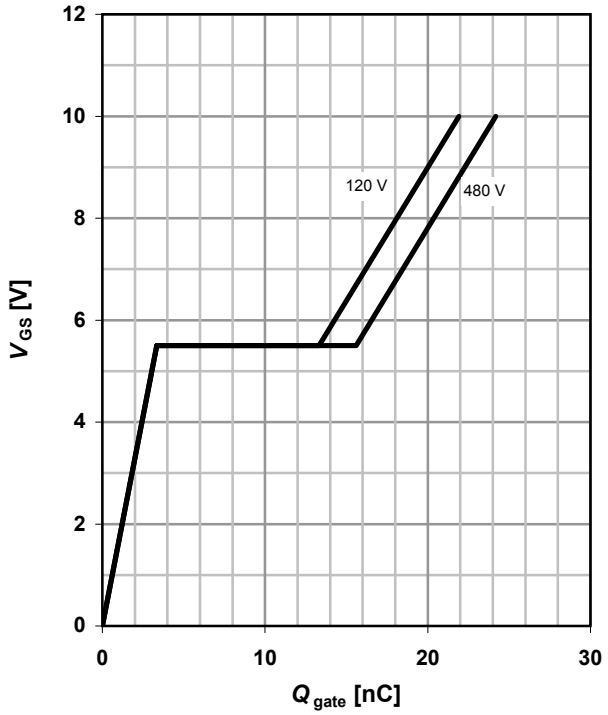
parameter: T_j



9 Typ. gate charge

V_{GS}=f(Q_{gate}); I_D=6.2 A pulsed

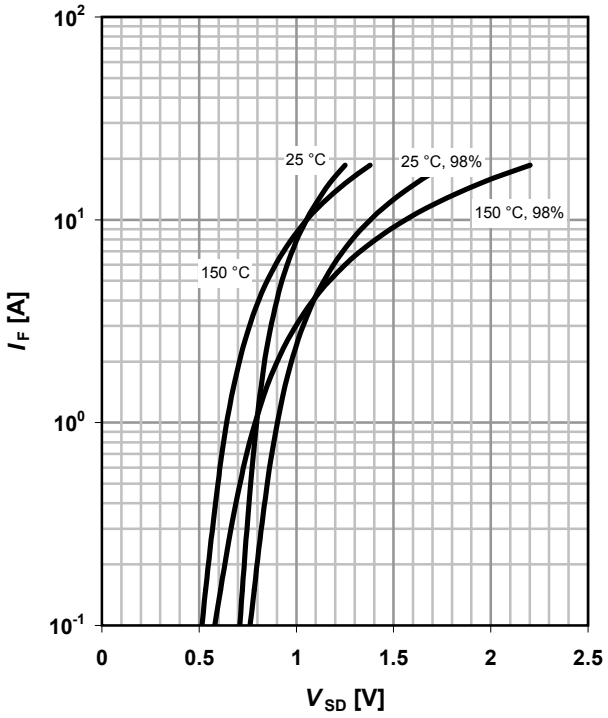
parameter: V_{DD}



10 Forward characteristics of reverse diode

I_F=f(V_{SD})

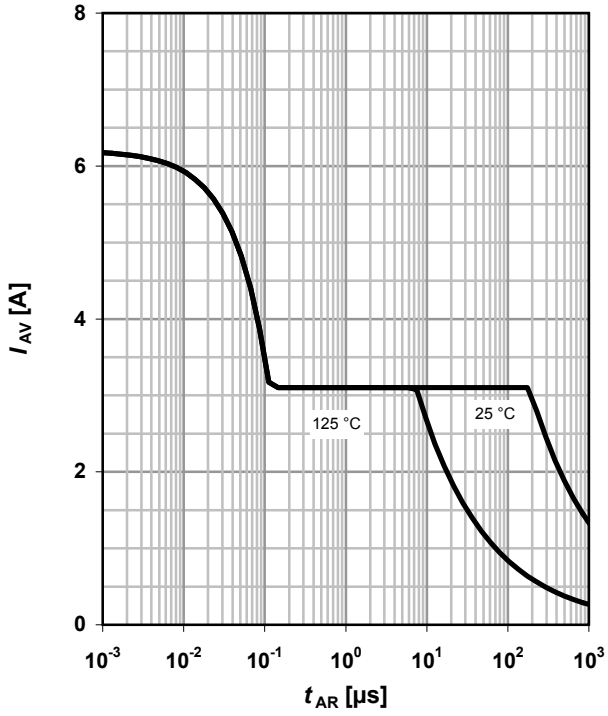
parameter: T_j



11 Avalanche SOA

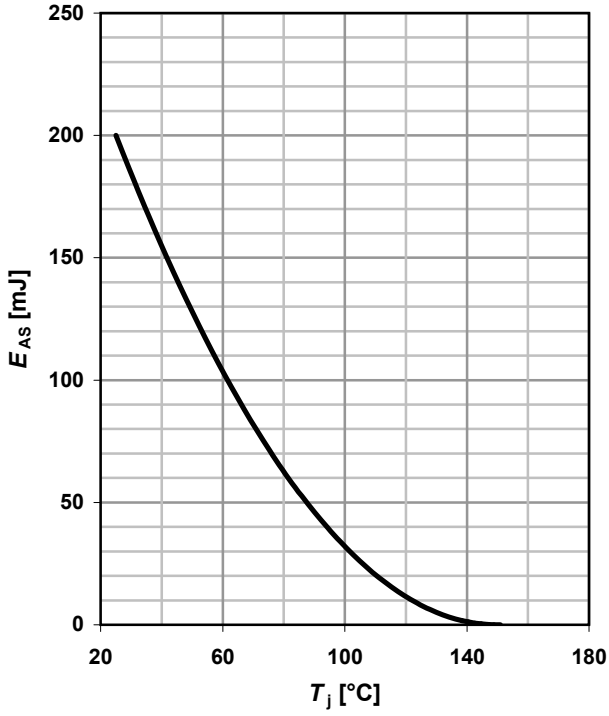
I_{AR}=f(t_{AR})

parameter: $T_{j(start)}$



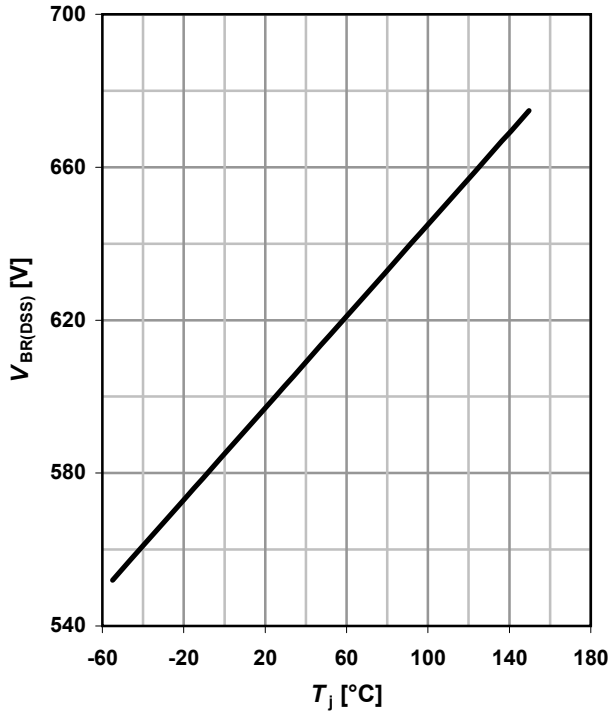
12 Avalanche energy

E_{AS}=f(T_j); I_D=3.1 A; V_{DD}=50 V



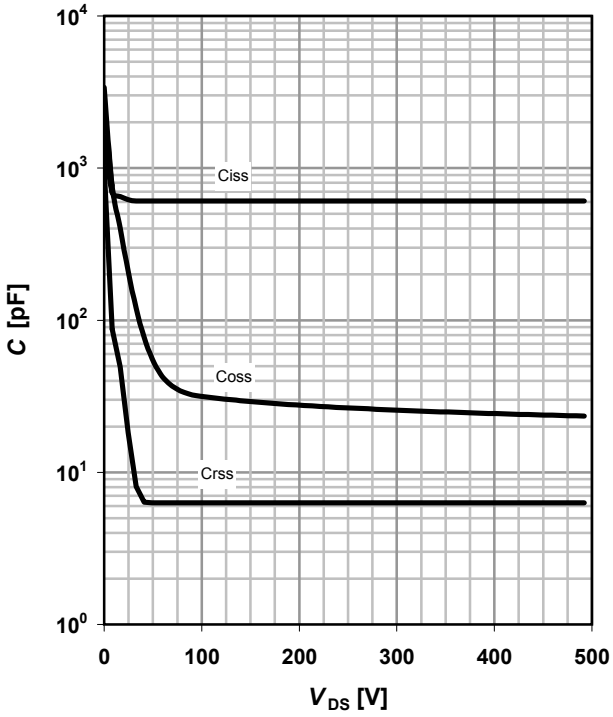
13 Drain-source breakdown voltage

$V_{BR(DSS)}$=f(T_j); I_D=0.25 mA



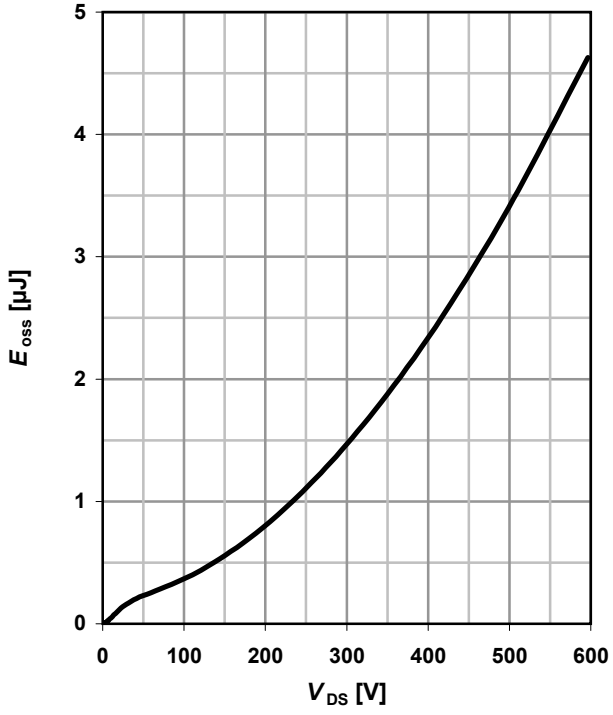
14 Typ. capacitances

C=f(V_{DS}); V_{GS}=0 V; f=1 MHz

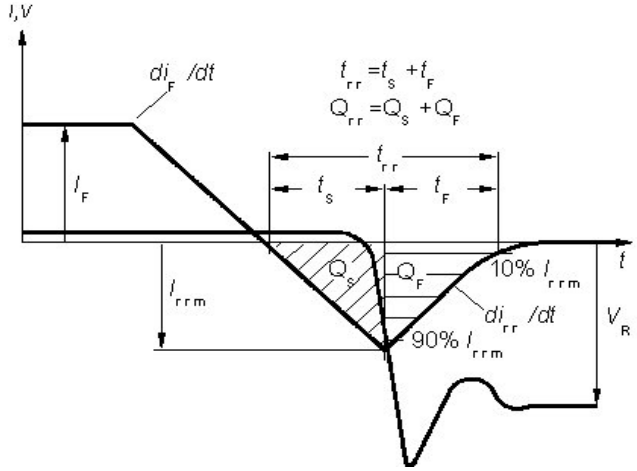


15 Typ. C_{oss} stored energy

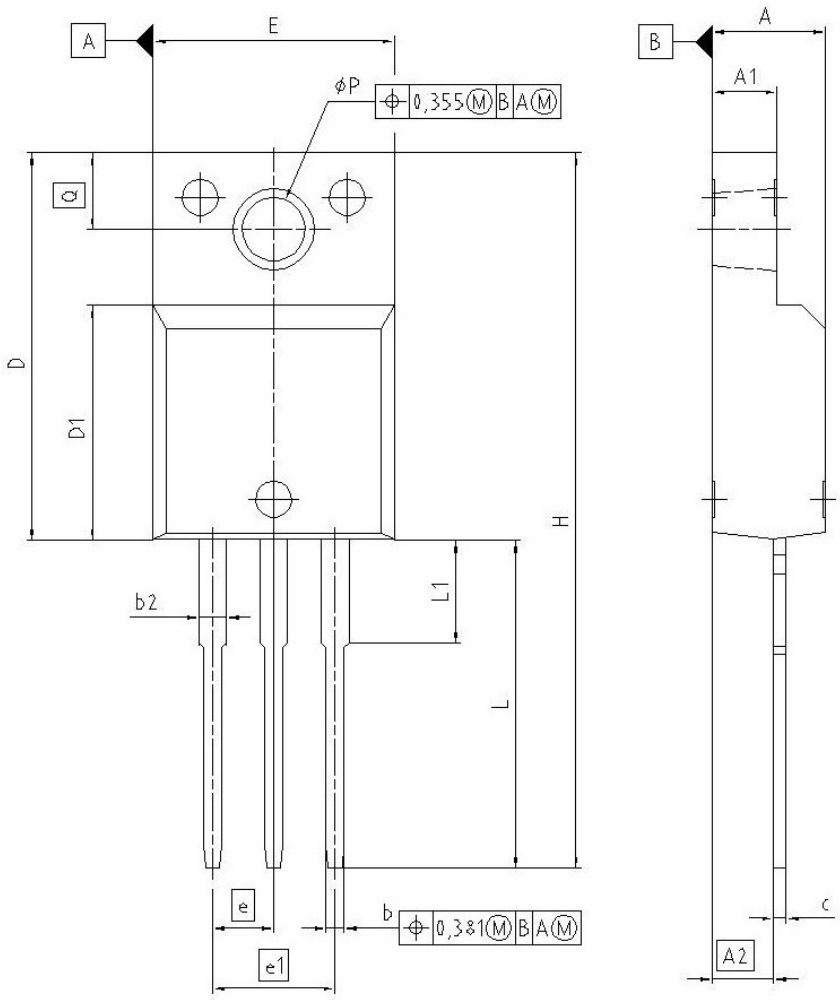
E_{oss}=f(V_{DS})



Definition of diode switching characteristics



PG-TO220-3-31 (FullPAK)



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.572	4.826	0.180	0.190
A1	2.573	2.827	0.101	0.111
A2	2.514	2.616	0.099	0.103
b	0.649	0.776	0.025	0.030
b2	1.143	1.509	0.045	0.059
c	0.449	0.627	0.017	0.027
D	15.863	16.117	0.624	0.634
D1	9.554	9.808	0.376	0.386
E	10.373	10.627	0.408	0.418
e	2.540		0.100	
e1	5.080		0.200	
N	3		3	
H	29.463	29.717	1.160	1.170
L	13.473	13.727	0.530	0.540
L1	3.175	3.429	0.125	0.135
øP	2.949	3.025	0.119	0.116
Q	3.149	3.251	0.124	0.128

REFERENCE	./..
SCALE	0 2.5 0 2.5 5mm
EUROPEAN PROJECTION	
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